

A High-Throughput Technique for Screening the Light Yield in Doped Rare-Earth Inorganic Scintillator Coatings

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Scintillators in X-ray imaging systems convert incident X-ray radiation into visible light, enabling the generation of digital images for applications in medical diagnostics, aerospace and security screening. X-rays transmitted through an object strike a scintillator, where they are absorbed and converted into visible photons. This visible light is then detected by a photodetector and processed to generate a digital image. Scintillator performance in X-ray imaging is strongly influenced by light yield. However, for many inorganic scintillators the light yield is sub-optimal. Increasing the light yield would enhance image resolution and improve contrast for greater detection efficiency, allowing lower X-ray intensity exposure and therefore improving scintillator and imaging performance.

This work presents the development of a high-throughput technique for screening a library of printed candidate X-ray scintillator powder materials, consisting of doped Lu₂O₃:Eu powders made at UCL. The high-density powders offered high X-ray absorption power to enhance detection efficiency compared to lower density elements. The candidate scintillator samples, along with a commercial benchmark powder, were processed as a doctor bladed high solid-loading ink (ca. 90 wt%) onto Mylar sheet or Tantalum foil (thickness of 150 μ m) and dried in air and cut into 15 mm diameter disks.

To assess the samples which might be suitable for X-ray scintillation applications, the candidate disk samples and the commercial benchmark powder were placed in a custom built, vertical rotating carousel with an integrated X-ray blocking front plate for sample isolation from peripheral X-rays (developed at the University of Southampton by Mark Mavrogordato), and introduced one at a time into a collimated X-ray beam set-up, incorporating an X-ray source, mirror and a Complementary Metal Oxide Semiconductor (CMOS) camera to capture a spatially resolved grayscale intensity image (**Figure 1**). The images were collated together using ImageJ software and a customised Python script to elucidate a brightness map of the sample library, where conversion to CIELAB colour space provided the lightness (L*) channel data as a measure of relative brightness used to identify the candidates with the highest light yield.

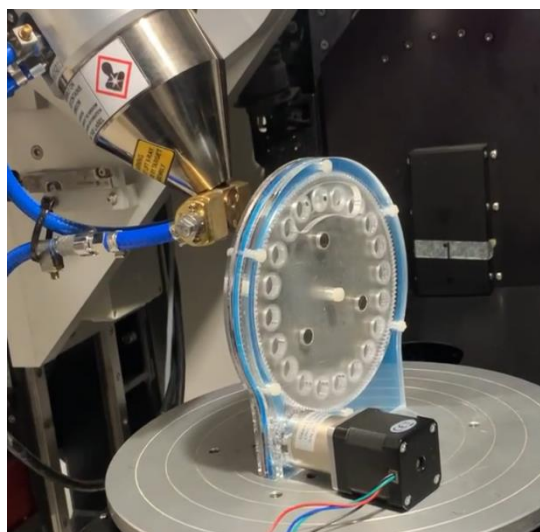


Figure 1. Image of the custom carousel sample holder with the rotation mechanism in front of the X-ray source, showcasing the sample disk positions for imaging.

In closing, the capability of this high-throughput imaging technique has been demonstrated using a series of doped lutetium-based phosphors and has identified a number of champion brightest doped sample compositions that will be scaled up and further optimised for next-generation scintillator applications.